

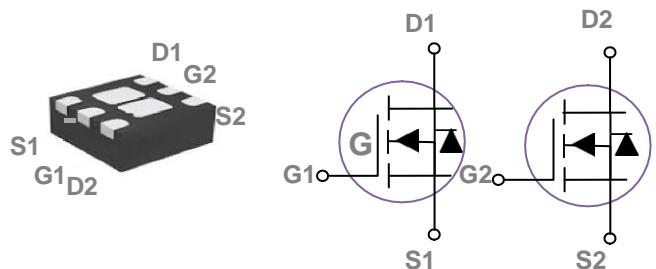
### General Description

These dual N Channel enhancement mode power fieldeffect transistors are using trench DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energypulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switchingapplications.

BVDSS	RDS(on)	ID
20V	22mΩ	6.5A

### DFN2X2 Dual 2EP Pin Configuration



### Features

- Fast switching
- Green Device Available
- Suit for 1.8V Gate Drive Applications
- Marking : WA

### Applications

- Notebook
- Load Switch
- Networking
- Hand-held Instruments

### Absolute Maximum Ratings T<sub>c</sub>=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	20	V
V <sub>GS</sub>	Gate-Source Voltage	±12	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>c</sub> =25°C)	6.5	A
	Drain Current - Continuous (T <sub>c</sub> =100°C)	4.3	A
I <sub>DM</sub>	Drain Current - Pulsed	20.8	A
P <sub>D</sub>	Power Dissipation (T <sub>c</sub> =25°C)	1.78	W
	Power Dissipation - Derate above 25°C	0.02	W/°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
T <sub>J</sub>	Operating Junction Temperature Range	-55 to 150	°C

### Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
R <sub>θJA</sub>	Thermal Resistance Junction to Ambient		100	°C/W

**Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**
**Off Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu\text{A}$	20			V
$\Delta BV_{DSS}/\Delta T_J$	$BV_{DSS}$ Temperature Coefficient	Reference to $25^\circ\text{C}, I_D=1\text{mA}$		0.02		$\text{V}/^\circ\text{C}$
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=20\text{V}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$			1	$\mu\text{A}$
		$V_{DS}=16\text{V}, V_{GS}=0\text{V}, T_J=125^\circ\text{C}$			10	$\mu\text{A}$
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 10\text{V}, V_{DS}=0\text{V}$			$\pm 100$	nA

**On Characteristics**

$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=4.5\text{V}, I_D=3\text{A}$		22	25	$\text{m}\Omega$
		$V_{GS}=2.5\text{V}, I_D=2\text{A}$		26	30	$\text{m}\Omega$
		$V_{GS}=1.8\text{V}, I_D=1.5\text{A}$		40	45	$\text{m}\Omega$
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\mu\text{A}$	0.3	0.6	1	V
				-2		$\text{mV}/^\circ\text{C}$
$g_{fs}$	Forward Transconductance	$V_{DS}=10\text{V}, I_D=2\text{A}$		4.4		S

**Dynamic and switching Characteristics**

$Q_g$	Total Gate Charge <sub>2,3</sub>	$V_{DS}=10\text{V}, V_{GS}=4.5\text{V}, I_D=3\text{A}$		5.8	10	nC
$Q_{gs}$	Gate-Source Charge <sub>2,3</sub>			0.6	1.5	
$Q_{gd}$	Gate-Drain Charge <sub>2,3</sub>			1.5	3	
$T_{d(on)}$	Turn-On Delay Time <sub>2,3</sub>	$V_{DD}=10\text{V}, V_{GS}=4.5\text{V}, R_G=25\Omega, I_D=1\text{A}$	---	2.9	6	ns
$T_r$	Rise Time <sub>2,3</sub>			8.4	16	
$T_{d(off)}$	Turn-Off Delay Time <sub>2,3</sub>			19.2	38	
$T_f$	Fall Time <sub>2,3</sub>			5.6	12	
$C_{iss}$	Input Capacitance			315	600	pF
$C_{oss}$	Output Capacitance	$V_{DS}=15\text{V}, V_{GS}=0\text{V}, F=1\text{MHz}$	---	50	80	
$C_{rss}$	Reverse Transfer Capacitance			40	60	

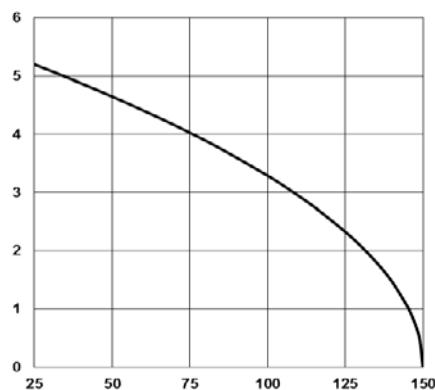
**Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous Source Current	$V_G=V_D=0\text{V}$ , Force Current			3.8	A
					7.6	A
$I_{SM}$	Pulsed Source Current					
$V_{SD}$	Diode Forward Voltage	$V_{GS}=0\text{V}, I_s=1\text{A}, T_J=25^\circ\text{C}$			1	V

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$ .
3. Essentially independent of operating temperature.

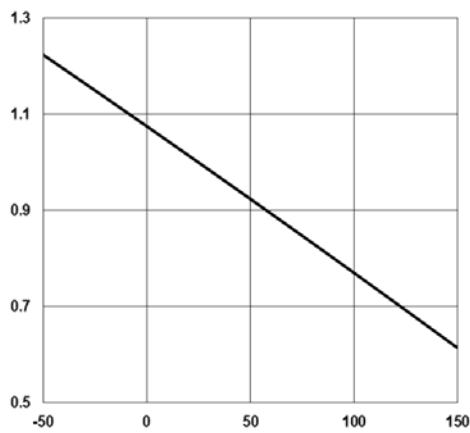
I<sub>D</sub>, Continuous Drain Current(A)



T<sub>C</sub> , Case Temperature (°C)

Fig.1 Continuous Drain Current vs. T<sub>C</sub>

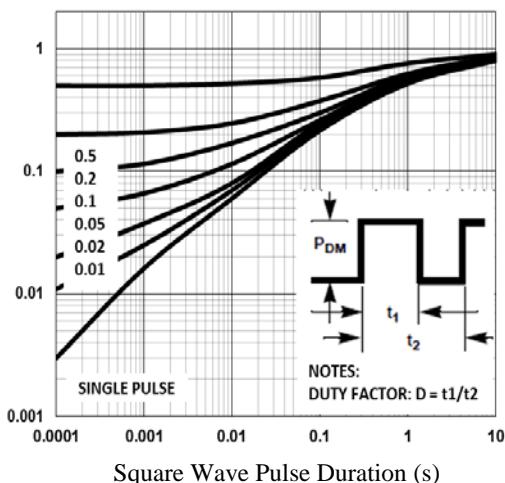
Normalized Gate Threshold Voltage(V)



T<sub>J</sub> , Junction Temperature (°C)

Fig.3 Normalized V<sub>th</sub> vs. T<sub>J</sub>

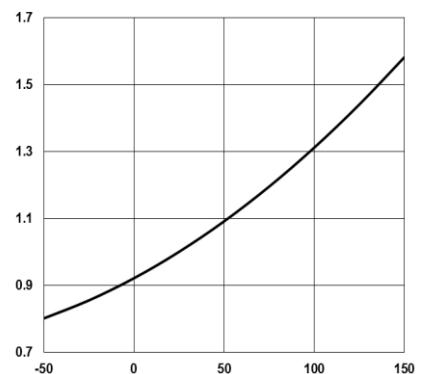
Normalized Thermal Response(R<sub>θ</sub> JA)



Square Wave Pulse Duration (s)

Fig.5 Normalized Transient Impedance

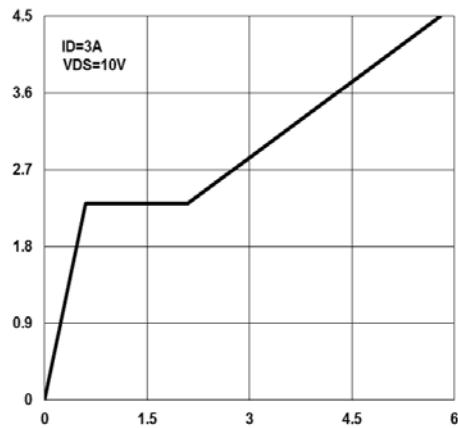
No rmalizedOnResistance(m)



T<sub>J</sub> , Junction Temperature (°C)

Fig.2 Normalized RDSON vs. T<sub>J</sub>

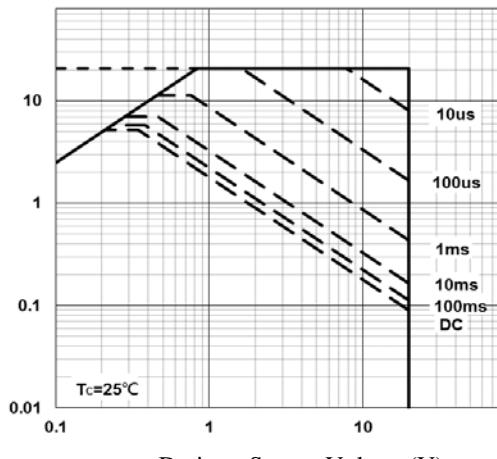
V<sub>G<sub>S</sub></sub>, Gate to Source Voltage(V)



Q<sub>G</sub> , Gate Charge (nC)

Fig.4 Gate Charge Waveform

I<sub>D</sub>, Continuous Drain Current(A)



V<sub>D<sub>S</sub></sub> , Drain to Source Voltage (V)

Fig.6 Maximum Safe Operation Area

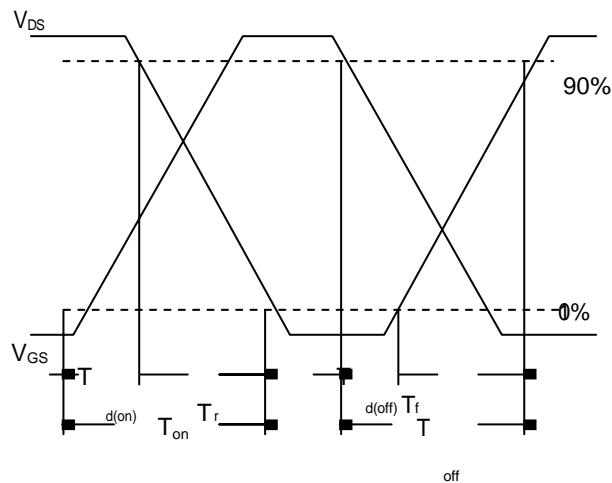


Fig.7 Switching Time Waveform

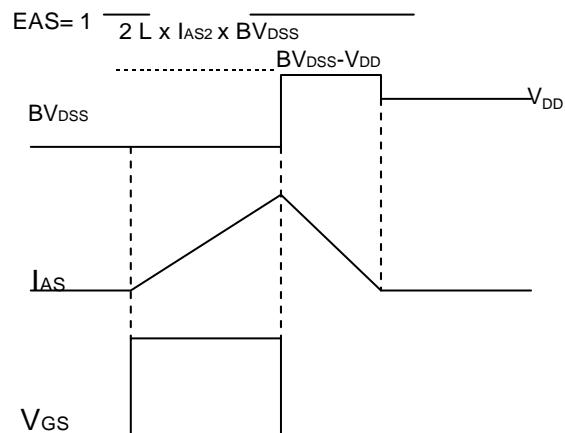
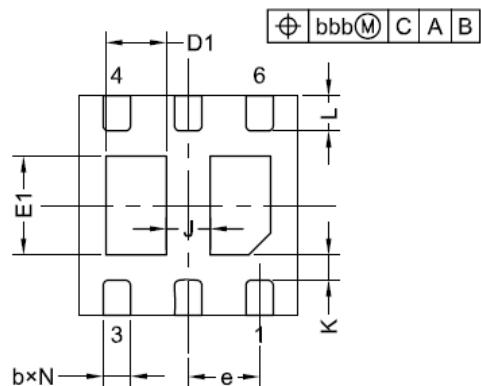
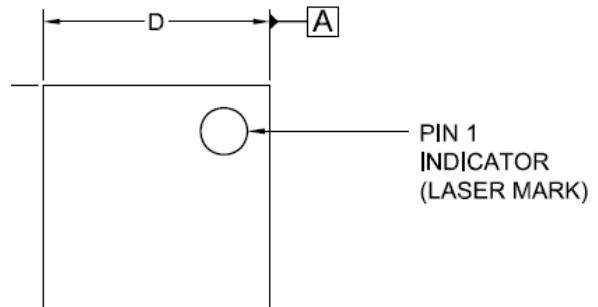


Fig.8 EAS Waveform

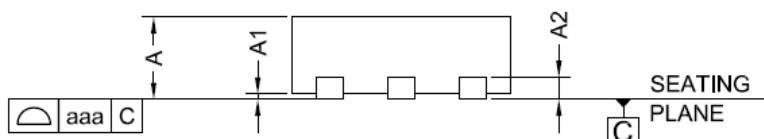
## PPAK2X2 Dual 2EP PACKAGE INFORMATION



BOTTOM VIEW



TOP VIEW



SIDE VIEW

COMMON DIMENSIONS  
(UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A2			0.203
b	0.20	0.25	0.30
D	1.95	2.00	2.05
D1	0.50	0.55	0.60
E	1.95	2.00	2.05
E1	0.85	0.90	0.95
e	0.65BSC		
L	0.27	0.32	0.37
J	0.40BSC		
K	0.20MIN		
N	6		
aaa	0.08		
bbb	0.10		

单击下面可查看定价，库存，交付和生命周期等信息

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